

**Search Notes**

Application/Control No.

10/621,417

Examiner

Hai C. Pham

Applicant(s)/Patent under  
Reexamination

MOTOYAMA, HAJIME

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	233, 241- 244, 25- 261	4/7/2005	HP
372	43, 107	4/7/2005	HP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST TEXT SEARCH	4/7/2005	HP